

Notice of References Cited		Application/Control No. 10/555,097	Applicant(s)/Patent Under Reexamination HANDA ET AL.	
		Examiner THANH Y. TRAN	Art Unit 2892	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,865,089	03-2005	Ho et al.	361/761
*	B	US-2004/0160751	08-2004	Inagaki et al.	361/763
*	C	US-6,498,553	12-2002	Tanaka et al.	336/83
*	D	US-2004/0158980	08-2004	Nakatani et al.	029/852
*	E	US-2004/0056344	03-2004	Ogawa et al.	257/686
*	F	US-2003/0015342	01-2003	Sakamoto et al.	174/250
*	G	US-5,745,984	05-1998	Cole et al.	29/834
*	H	US-7,045,391	05-2006	Lin, Chian-Chi	438/109
*	I	US-7,057,896	06-2006	Matsuo et al.	361/704
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.